

## Electronic Supplementary Information (ESI)

A film of rutile TiO<sub>2</sub> pillars with well-developed facets on an  $\alpha$ -Ti substrate as a photoelectrode for improved water splitting

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**Sample preparation procedure.** To prepare an amorphous TiO<sub>2</sub> nanotube array film, a titanium foil (30 mm × 10 mm × 0.25 mm) was immersed in a mixed solution of glycol and water with a volume ratio of 9:1 containing 0.25 wt% NH<sub>4</sub>F in a two-electrode cell with a Pt foil as counter electrode. Anodization was conducted at 60 V for 3 h. As-prepared films were washed with deionized water several times to remove any residual dissolvable ions. Then the top amorphous nanotube array film can be easily removed through ultrasonic treatment in 30 wt% H<sub>2</sub>O<sub>2</sub> solution, and a nanotube-free compact amorphous film was obtained.

To prepare a rutile TiO<sub>2</sub> pillar film, the compact amorphous film was heated at 550 °C for 1 h in oxygen atmosphere with a pressure of 10<sup>3</sup> Pa. The temperature ramping rate used was 5 °C /min. A similar preparation procedure with a 3 °C/min ramping rate was also used to crystallize an anatase TiO<sub>2</sub> nanotube array film on a Ti foil.

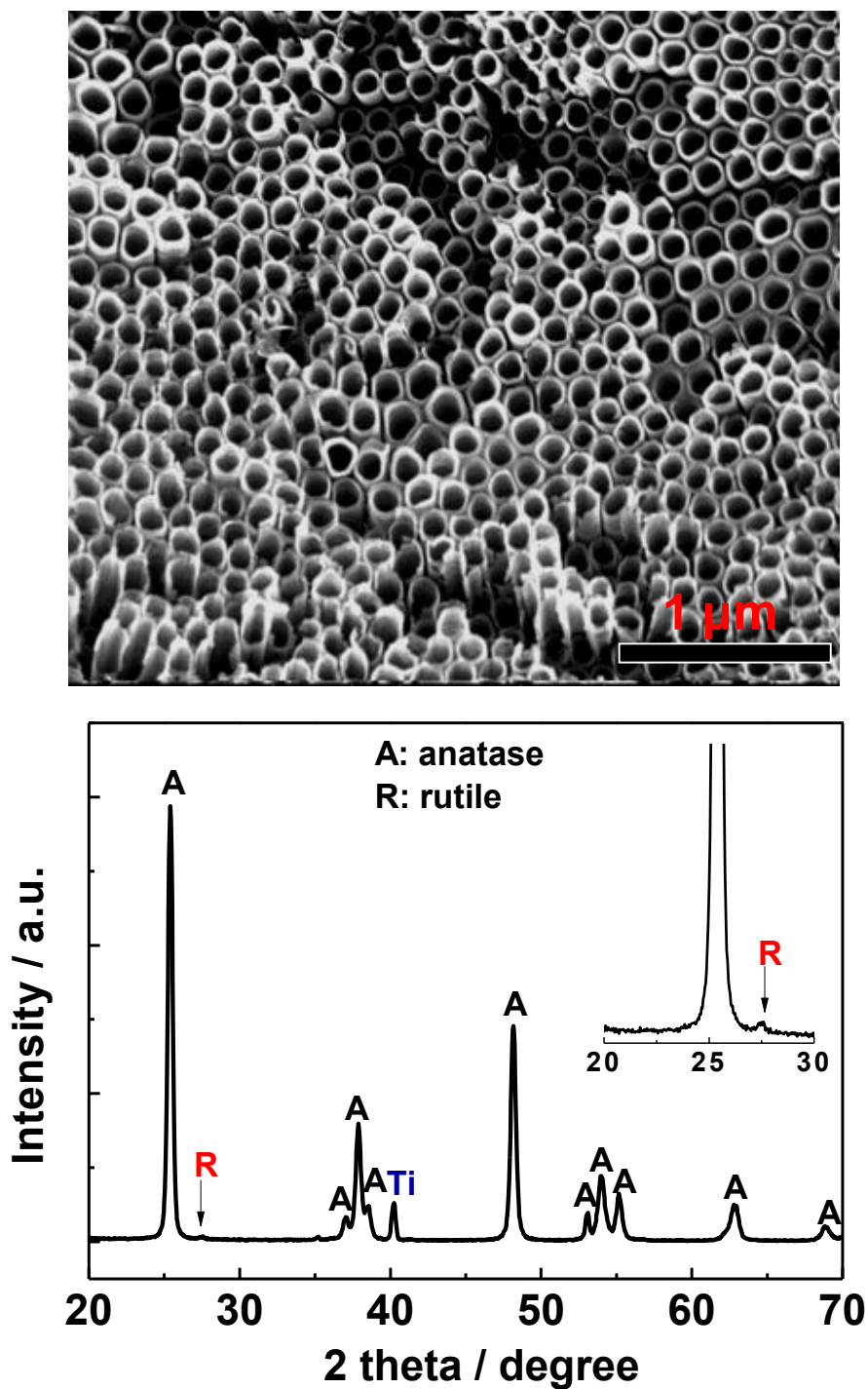
**Characterization.** X-ray diffraction patterns of the samples were recorded on a Rigaku diffractometer using Cu irradiation. Their morphology was determined by using scanning electron microscopy (SEM) and transmission electron microscopy (TEM) performed on a Nova NanoSEM 430 and Tecnai F30. The chemical state of Ti

in TiO<sub>2</sub> was analyzed using X-ray photoelectron spectroscopy (Thermo Escalab 250, a monochromatic Al K $\alpha$  X-ray source). Binding energy was referenced to the C 1s peak (284.6 eV) arising from adventitious carbon. The optical absorbance spectra of the samples were recorded in a UV-visible spectrophotometer (JACSCO-550).

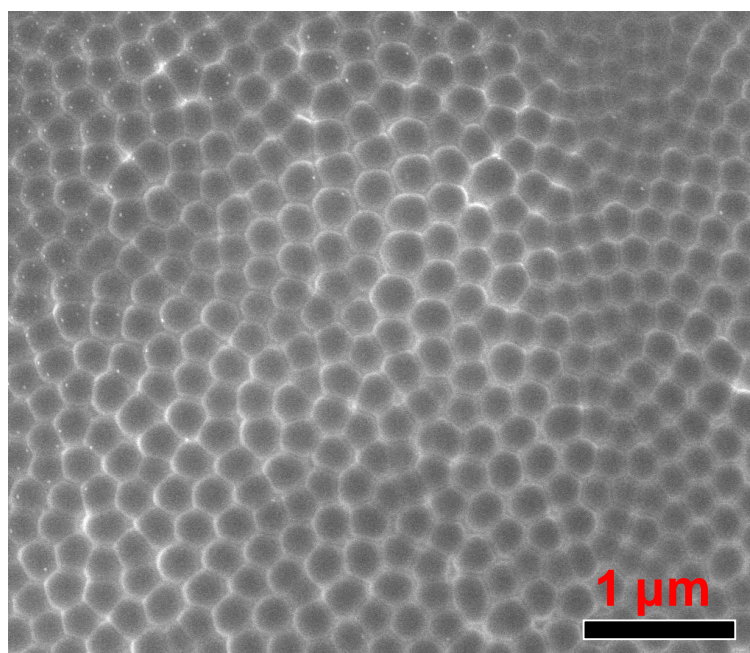
**Photoelectrochemical measurements.** Photoelectrochemical measurements were carried out in a quartz cell with a conventional three-electrode process, where a TiO<sub>2</sub> photoelectrode as anode, a Pt foil and Ag/AgCl electrode served as the working electrode, counter electrode and reference electrode, respectively. Electrolyte was 0.2 M Na<sub>2</sub>SO<sub>4</sub> aqueous solution. The light source in the above photoreactivity experiments was a 300 W Xe lamp (Beijing Trusttech Co. Ltd, PLS-SXE-300UV). The photoanode surface area illuminated was 1 cm<sup>2</sup>, and the scanning rate was 0.1 V s<sup>-1</sup>.

The incident photon-to-current conversion efficiency (IPCE) was calculated according to the following equation:

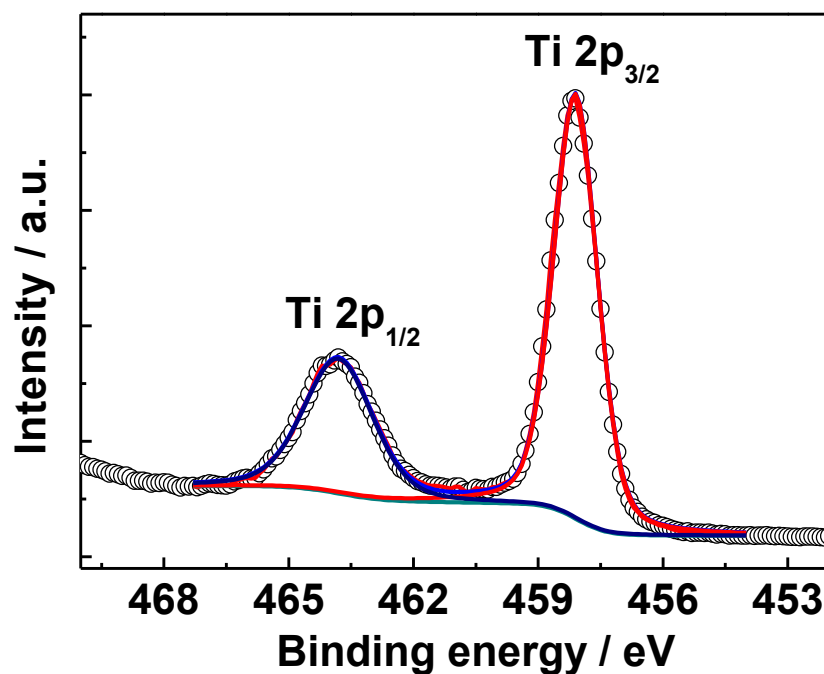
$$\text{IPCE (\%)} = [1240 \times \text{photocurrent density (mAcm}^{-2}\text{)}] / [\text{wavelength (nm)} \times \text{photon flux (mW cm}^{-2}\text{)}] \times 100\%$$



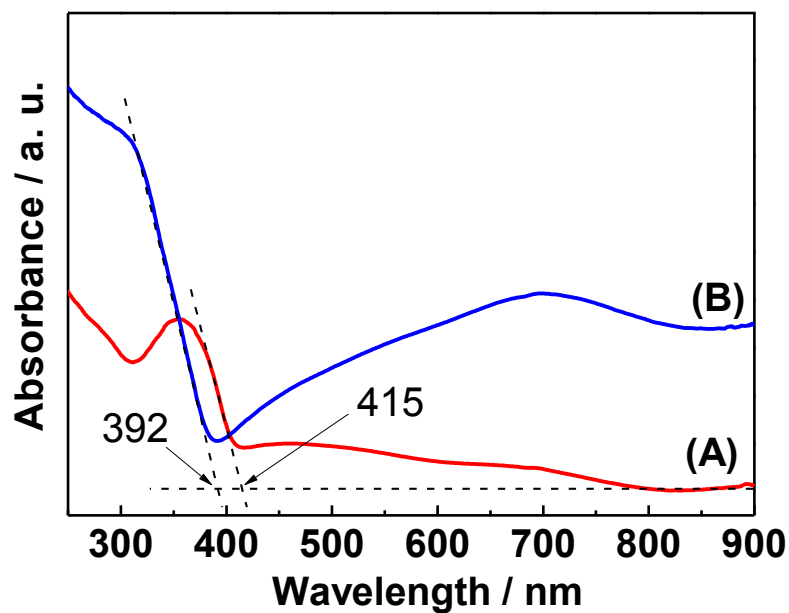
**Fig. S1** SEM image and XRD patterns of a crystalline TiO<sub>2</sub> film on a Ti foil by directly heat treating an as-prepared amorphous TiO<sub>2</sub> film consisting of both the top nanotube and compact film.



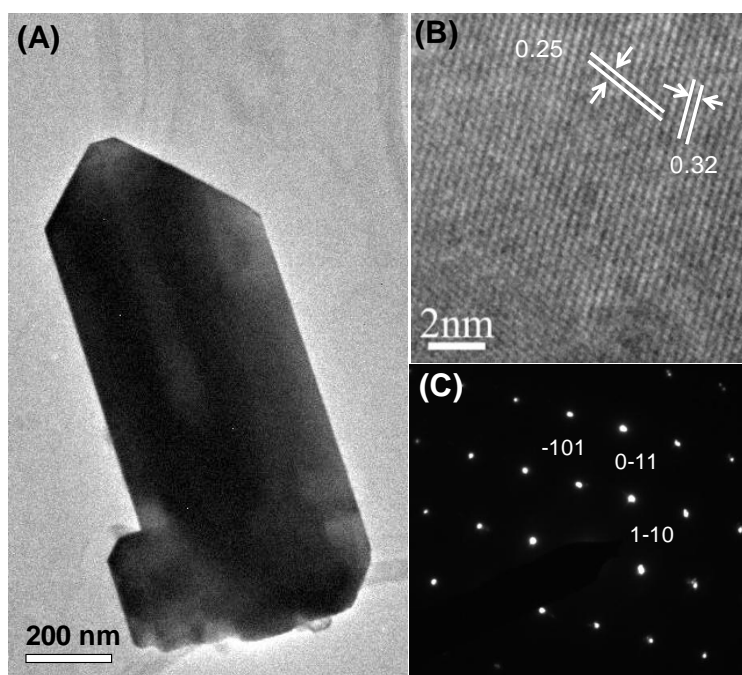
**Fig. S2** SEM image of a compact amorphous TiO<sub>2</sub> film on a Ti foil left after removing the top amorphous nanotube array film. The topmost honeycomb-like pores were formed due to the slight embedding of the close ends of nanotubes in the compact amorphous TiO<sub>2</sub> film during anodization growth.



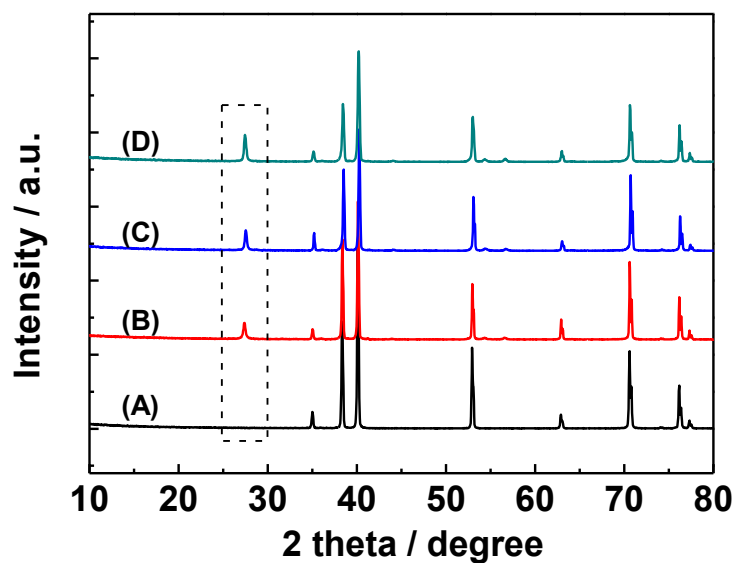
**Fig. S3** High resolution XPS spectrum of Ti 2p in the prepared rutile TiO<sub>2</sub> pillars on a Ti foil.



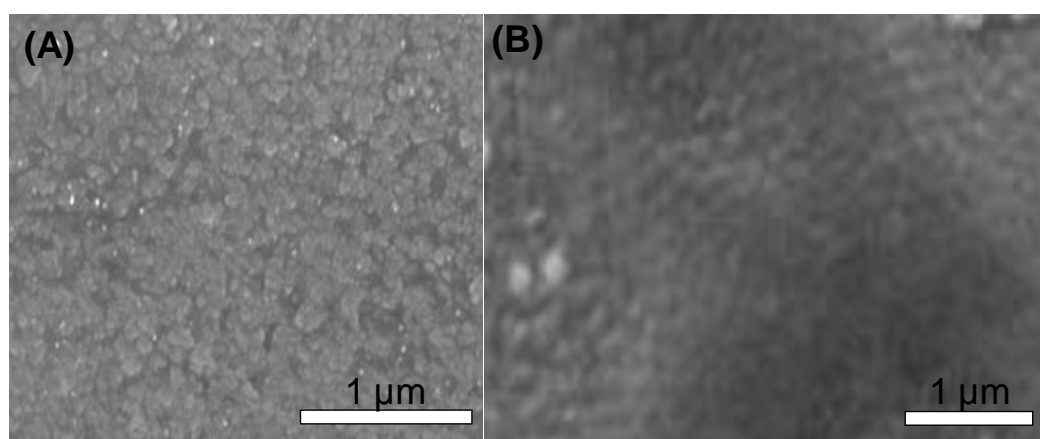
**Fig. S4** UV-visible absorption spectra of (A) a rutile  $\text{TiO}_2$  pillar film on a Ti foil and (B) an anatase  $\text{TiO}_2$  nanotube array film on a Ti foil.



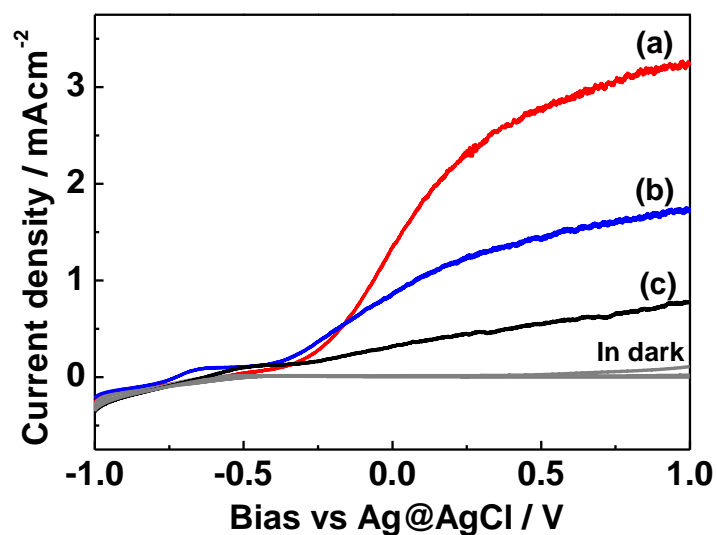
**Fig. S5** (A), TEM image of a typical rutile  $\text{TiO}_2$  pillar with well-developed facets; (B), high resolution TEM image of another single rutile  $\text{TiO}_2$  pillar scraped from the rutile  $\text{TiO}_2$  pillar film on a Ti foil; (C), corresponding selected area electron diffraction pattern of (B).



**Fig. S6** Time dependence X-ray diffraction pattern evolution of an amorphous compact TiO<sub>2</sub> film on a Ti foil by heating at 550 °C in oxygen atmosphere with a pressure of 10<sup>3</sup> Pa: (A), 0 min; (B), 10 min; (C), 30 min; (D), 50 min.



**Fig. S7** SEM images of the rutile TiO<sub>2</sub> films on a Ti foil obtained by heating a compact amorphous TiO<sub>2</sub> film at 550 °C for 1 h in oxygen atmosphere with a pressure of (A) 10 Pa and (B) 10<sup>5</sup> Pa.



**Fig. S8** Applied potential bias-dependent photocurrent density: a rutile TiO<sub>2</sub> pillar photoelectrode (a), the rutile TiO<sub>2</sub> films on a Ti foil obtained by heating a compact amorphous TiO<sub>2</sub> film at 550 °C for 1 h in oxygen atmosphere with a pressure of (b) 10<sup>5</sup> Pa and (c) 10 Pa.